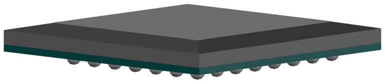
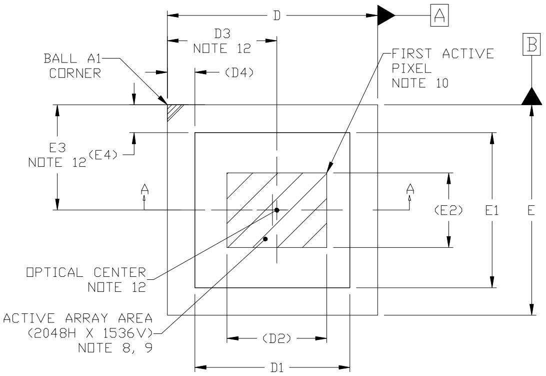
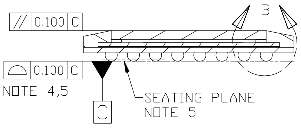


IBGA63 9.5x9.5x1.54, 1.00P
CASE 503AM
ISSUE B

DATE 18 MAY 2023



TOP VIEW

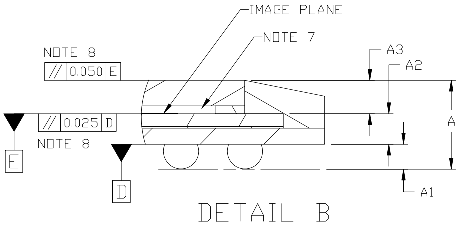


SECTION A-A

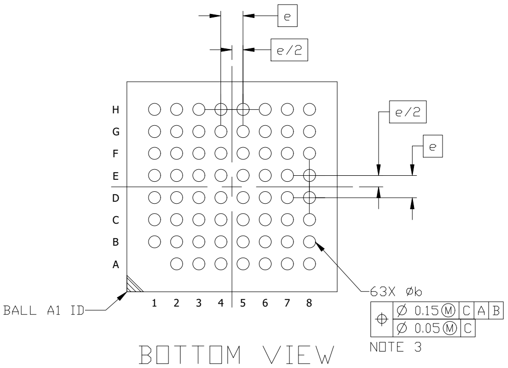
NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS [mm].
3. SOLDER BALL DIAMETER IS MEASURED AT THE MAXIMUM SOLDER BALL DIAMETER PARALLEL TO DATUM C.
4. COPLANARITY APPLIES TO THE SPHERICAL CROWNS OF THE SOLDER BALLS.
5. DATUM C, THE SEATING PLANE IS DEFINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.
6. GLASS: 0.400 THICKNESS; REFRACTIVE INDEX = 1.52; AR COATING R<1% 420-850nm (EACH SIDE).
7. AIR GAP BETWEEN GLASS AND PIXEL ARRAY: 0.125 THICKNESS.
8. PARALLELISM APPLIES ONLY TO THE ACTIVE ARRAY.
9. MAXIMUM ROTATION OF ACTIVE ARRAY RELATIVE TO DATUMS A AND B IS ±0.5°.
10. REFER TO THE DEVICE DATA SHEET FOR TOTAL PIXEL ARRAY DEFINITIONS.
11. PACKAGE CENTER (X, Y) = (0.000, 0.000).
12. OPTICAL CENTER RELATIVE TO PACKAGE CENTER (X, Y) = (0.200, 0.000).

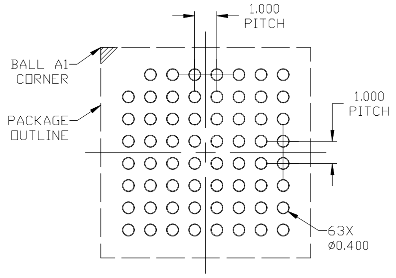
DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	~	~	1.540
A1	0.340	0.390	0.440
A2	0.425	0.475	0.525
A3	0.475	0.525	0.575
b	0.450	0.500	0.550
D	9.425	9.500	9.575
D1	6.900	7.000	7.100
D2	4.506 REF.		
D3	4.875	4.950	5.025
D4	1.250 REF.		
E	9.425	9.500	9.575
E1	6.900	7.000	7.100
E2	3.379 REF.		
E3	4.675	4.750	4.825
E4	1.250 REF.		
e	1.000 BSC.		



DETAIL B
SCALE 2:1



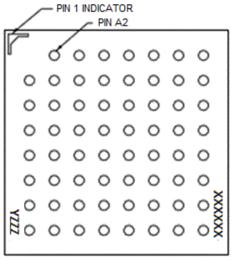
BOTTOM VIEW



RECOMMENDED MOUNTING FOOTPRINT*

* FOR ADDITIONAL INFORMATION ON OUR Pb-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
Y = Year
ZZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “▪”, may or may not be present. Some products may not follow the Generic Marking.

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